

RF field effect transistors based on graphene

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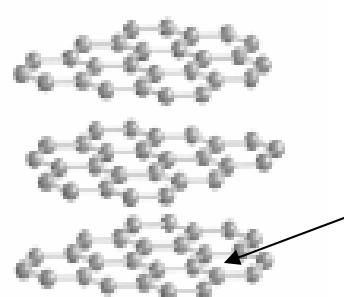
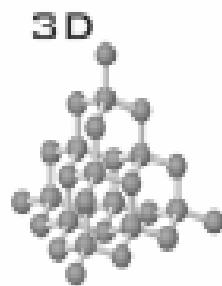
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³Politehnica University of Bucharest, Electronics Dept., 1-3 Iuliu Maniu Av., 061071 Bucharest, Romania

⁴Univ. Bucharest, Physics Dept., P.O. Box MG-11, 077125 Bucharest, Romania

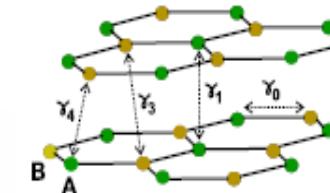
⁵LAAS CNRS, 7 Avenue du Colonel Roche, 31077 Toulouse Cedex 4, France

Carbon-based materials

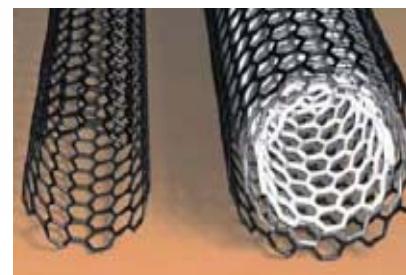
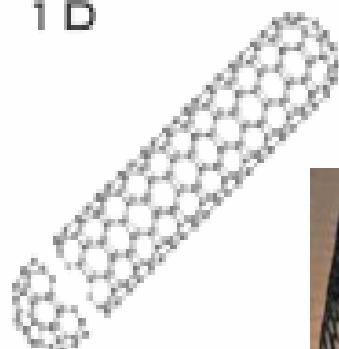


GRAPHENE
=one atom
thick
material

2 D



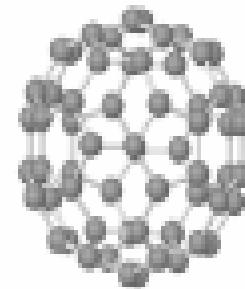
1 D



S. Iijima, Nature 354 (1991) 56

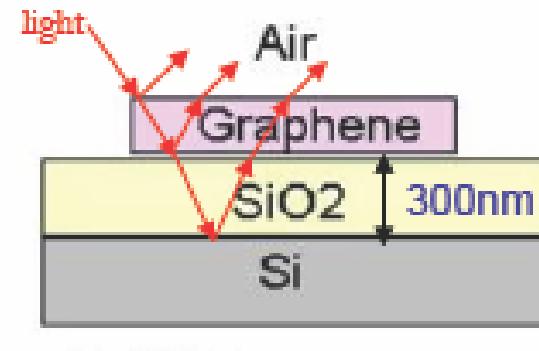
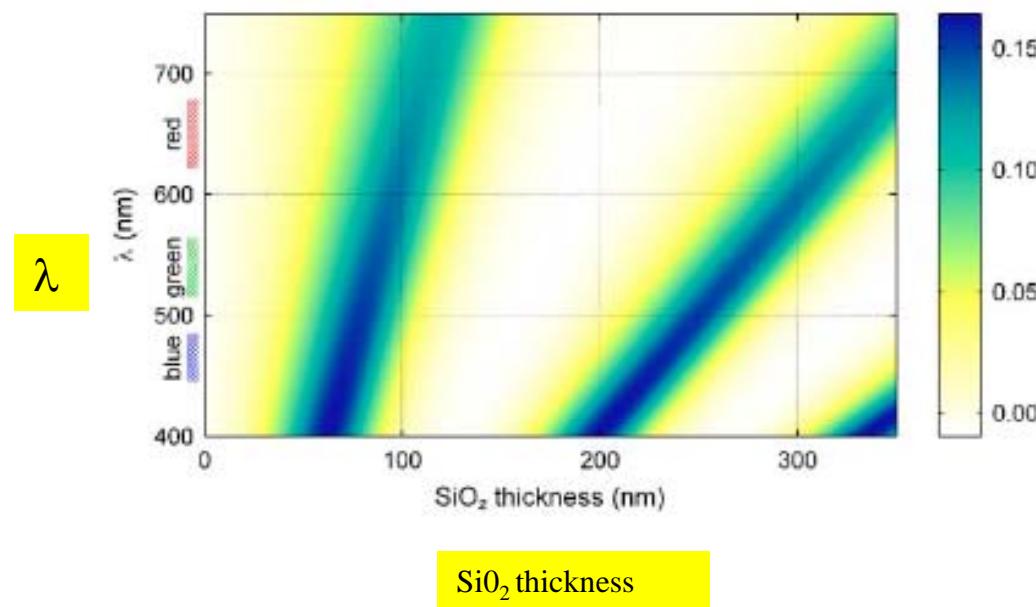
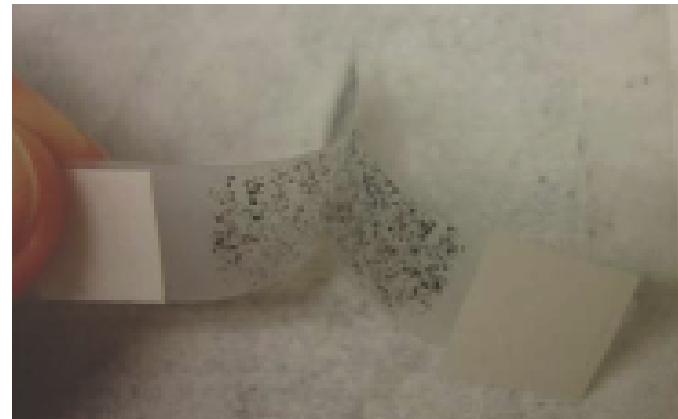
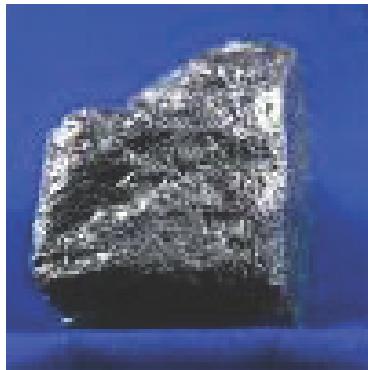
K.S. Novoselov et al., Science 306 (2004)
666
Theory: P.R. Wallace, Phys. Rev. 71
(1947) 622

0 D



H.W. Kroto et al., Nature 318
(1985) 162

"exfoliation" (scotch tape)



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1 layer

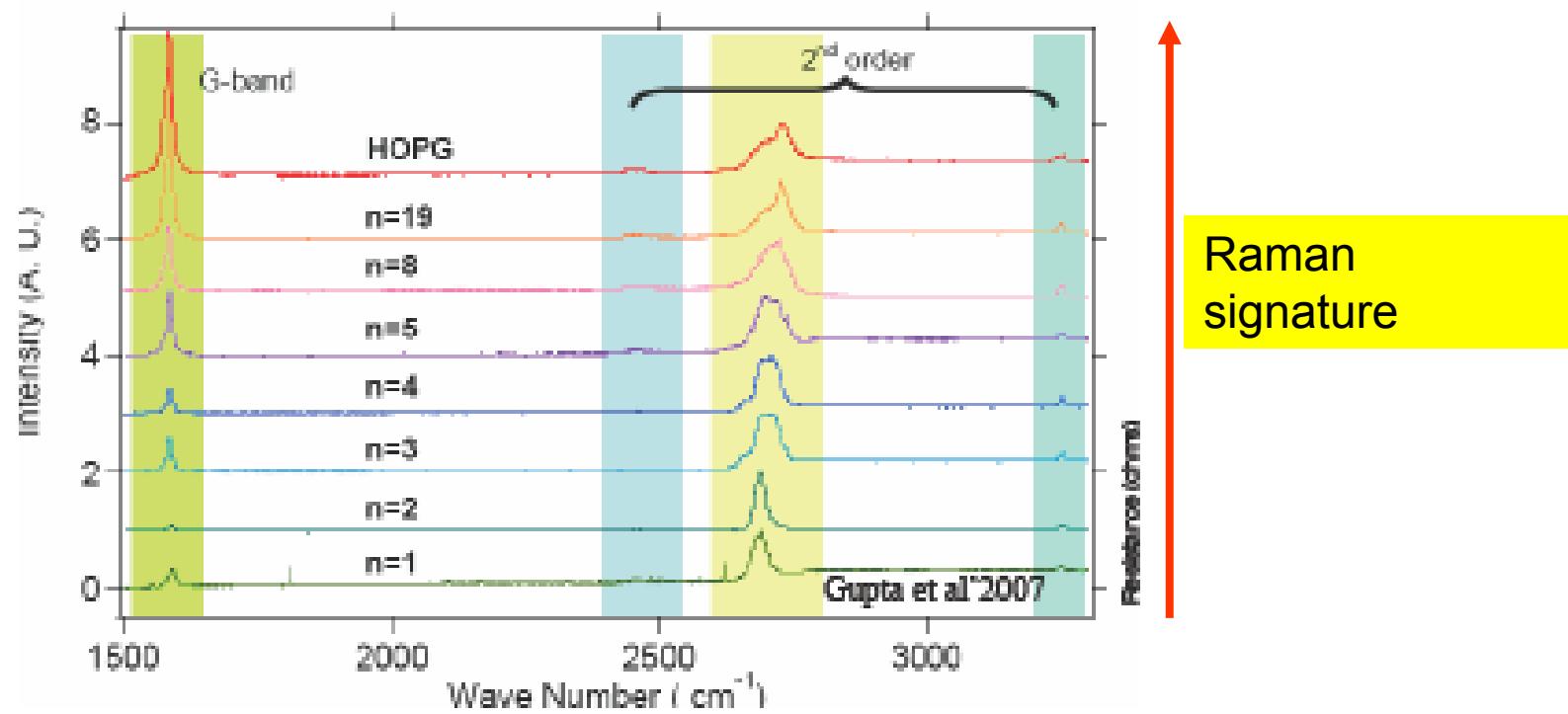
2 layers

3 layers

Ni et al' 2007

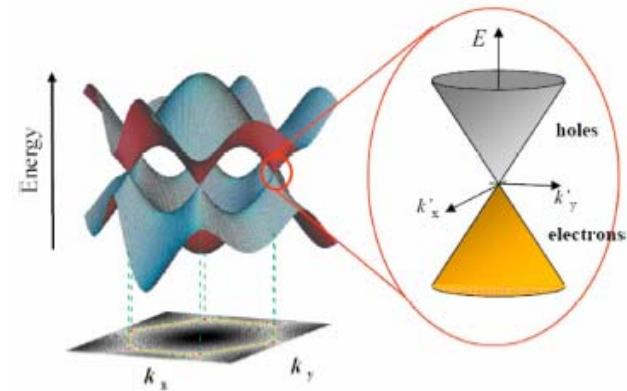
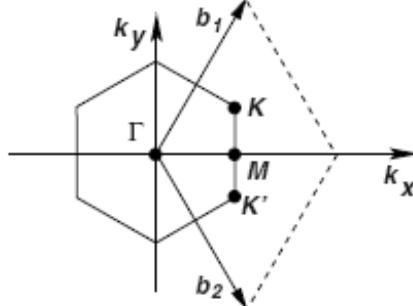
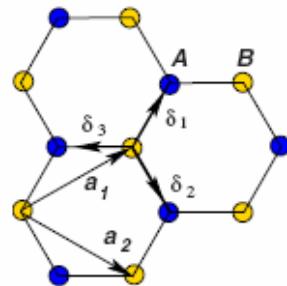
7 layers

9 layers



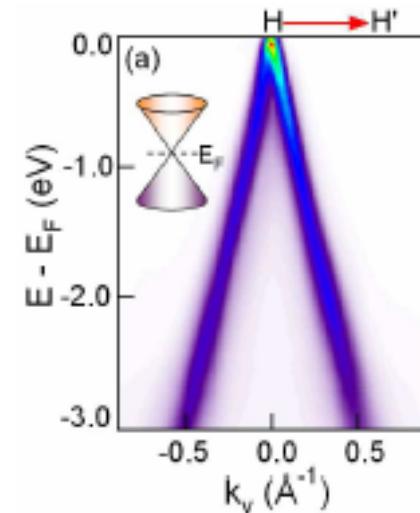
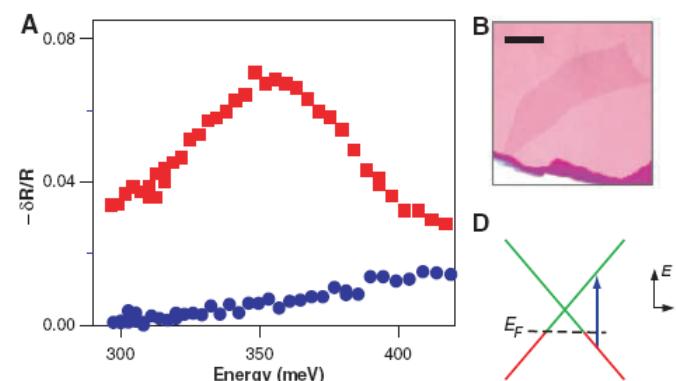
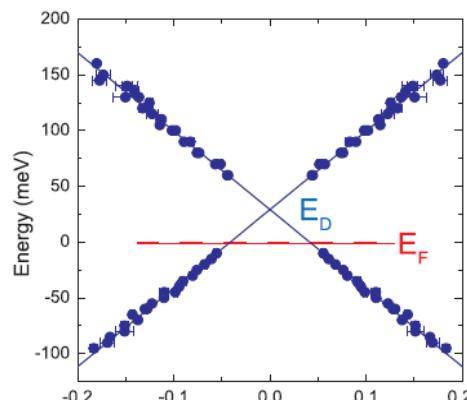
Electronic band structure

Determined by the π bonds formed by hybridization of the p_z orbitals of different C atoms



$$E_{\pm}(k) = \pm \hbar v_F |k|$$

$$v_F \cong c/300$$

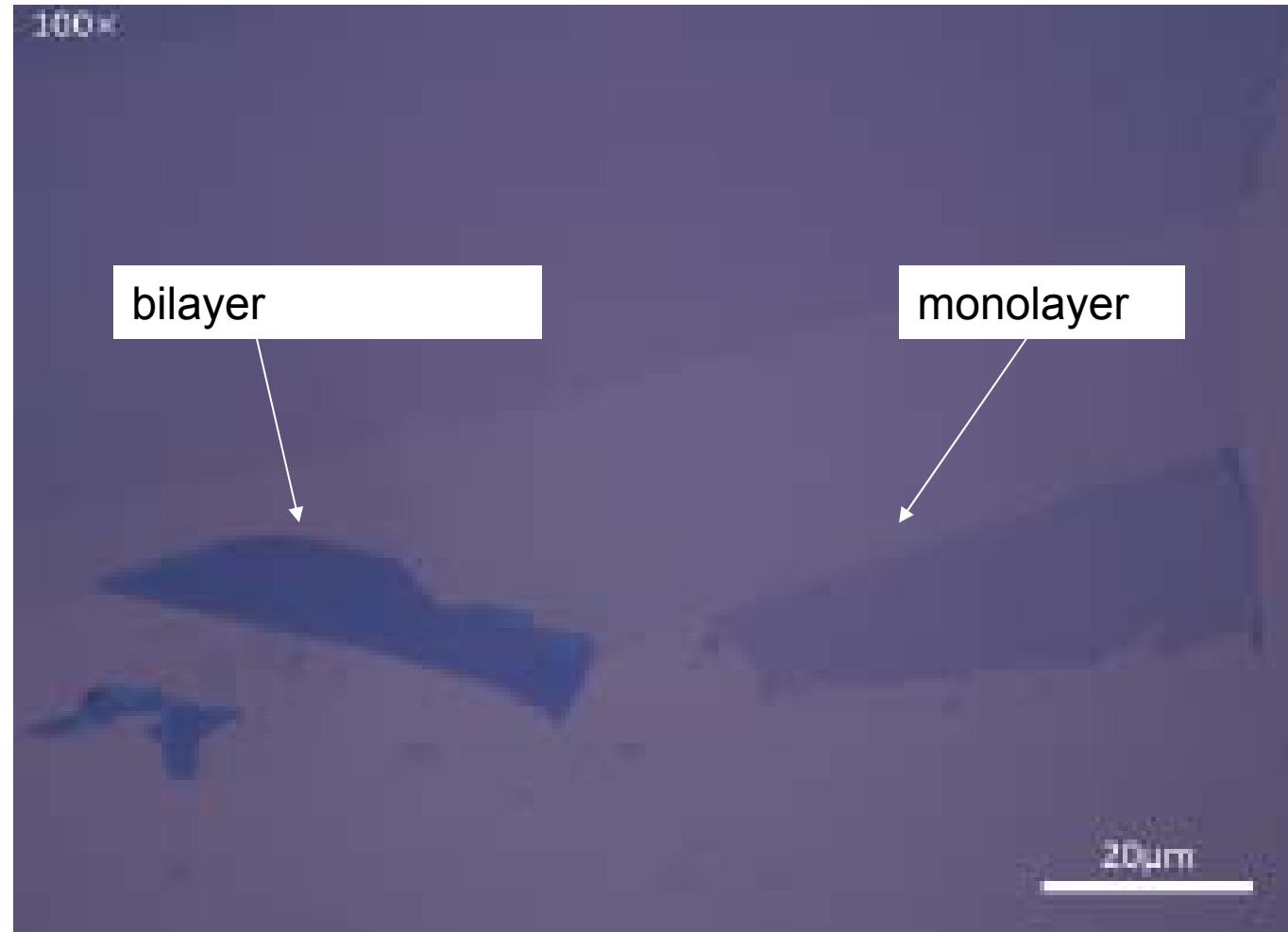


D.L. Miller et al., Science 324 (2009)
924

F. Wang et al., Science 320
(2008) 206

S.Y.Zhou et al., Nature
Physics 2 (2006) 595

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Graphene –the wonder material!!!

Parameter	Value and units	Observations
Thermal conductivity	5000 W/mK	Better thermal conductivity than in most crystals
Young modulus	1.5 TPa	Ten times greater than in steel
Mobility	40 000 cm ² V ⁻¹ s ⁻¹	At room temperature (intrinsic mobility) maximum mobility : 200 000 cm ² V ⁻¹ s ⁻¹) on suspended graphenes
Mean free path (ballistic transport)	≈ 400 nm	At room temperature
Electron effective mass	0.06 m_0	At room temperature
Hole effective mass	0.03 m_0	At room temperature
Fermi velocity	c/300=1000000 m/s	At room temperature

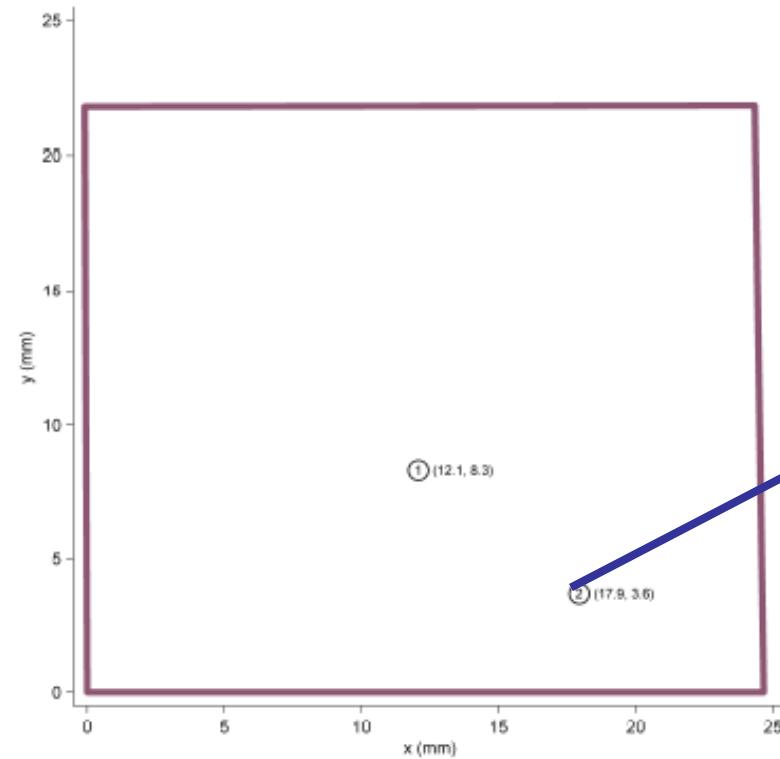
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Sample MD04 Datasheet

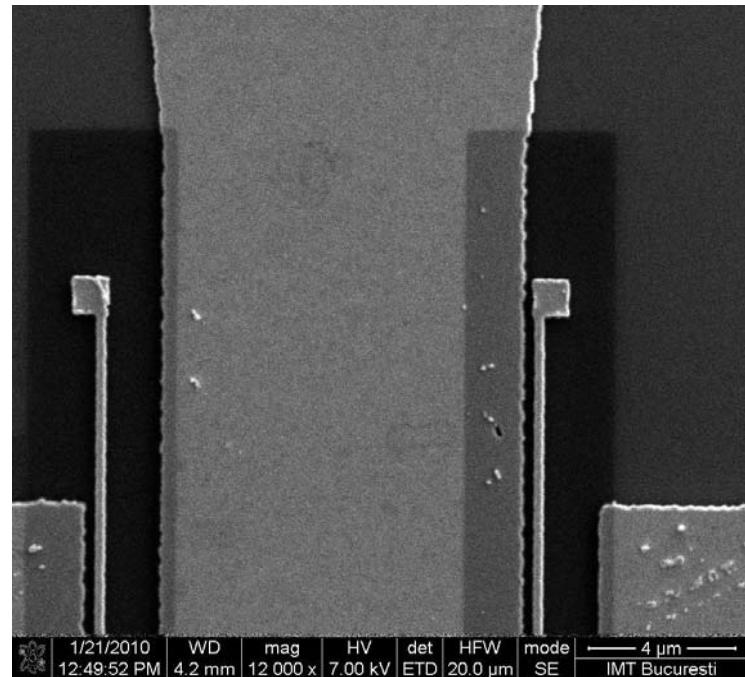
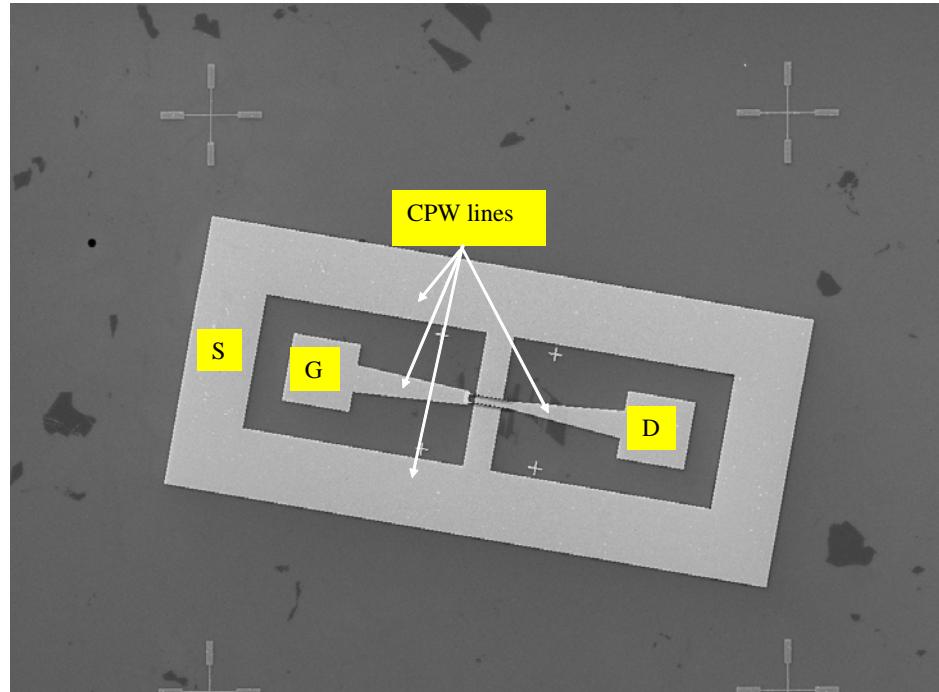
Parent Wafer

Supplier	Mircea Dragoman
Resistivity	High
Oxide	\approx 300 nm dry thermal oxide

Substrate Map

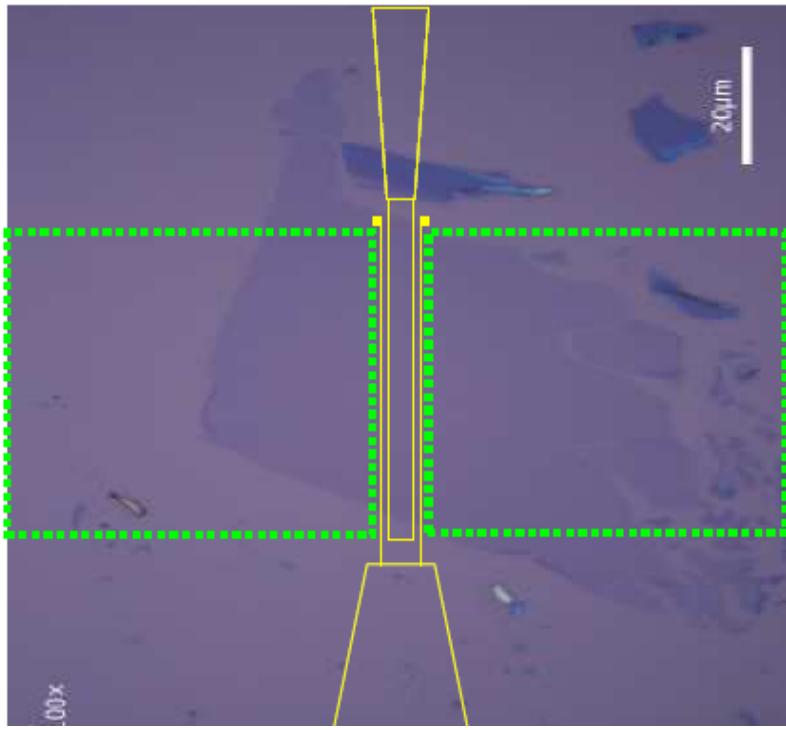


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The relevant dimensions of the graphene FET are: gate length 200 nm, source-drain distance 2 μ m and source-drain width 40 μ m . The gate dielectric is a 100 nm thick PMMA layer

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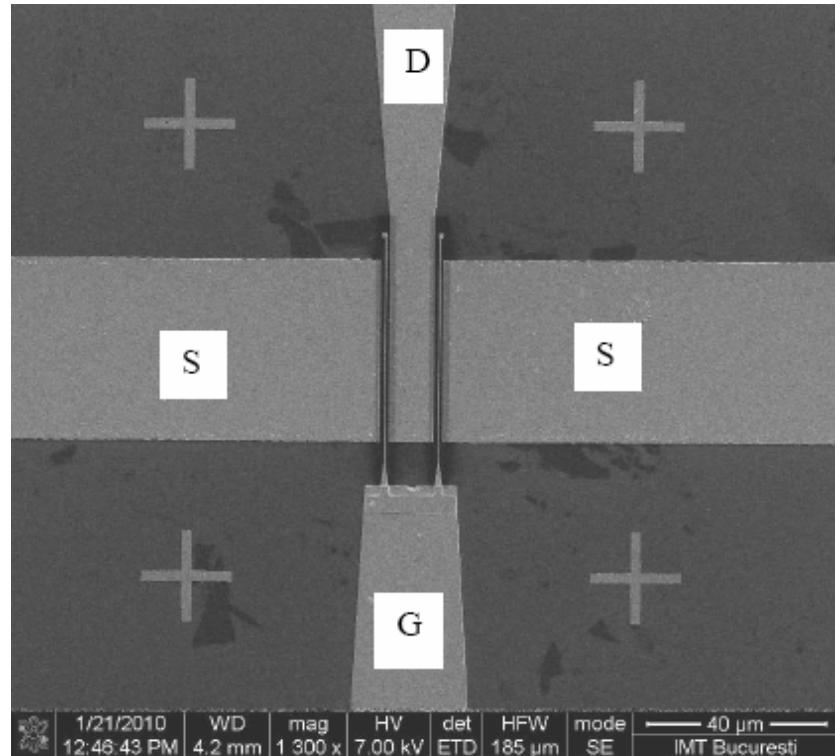
Graphene on doped Si with 300 nm

E-beam lithography
e e

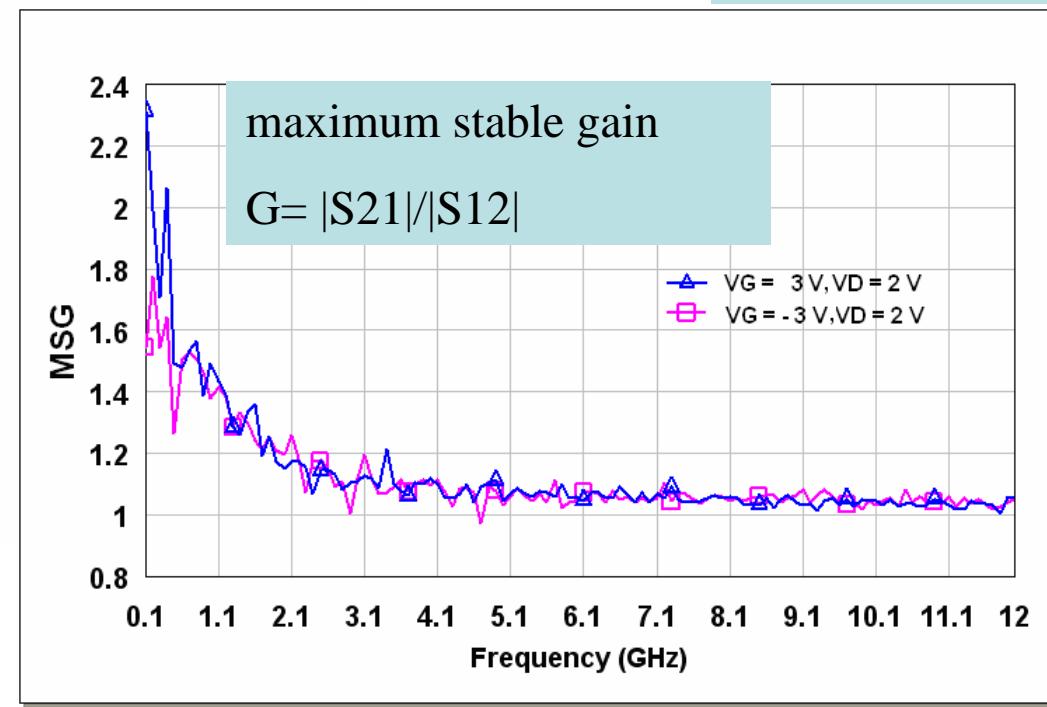
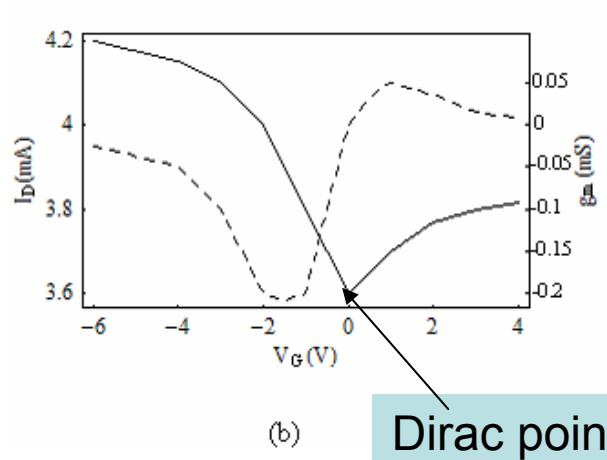
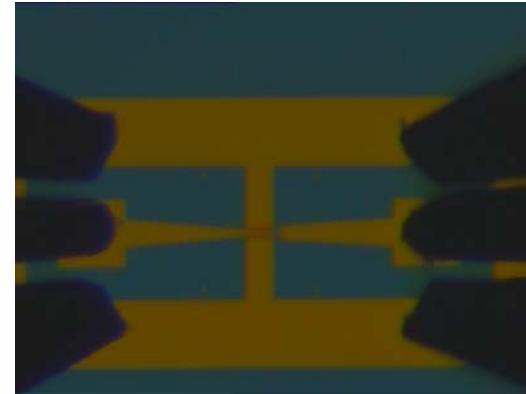
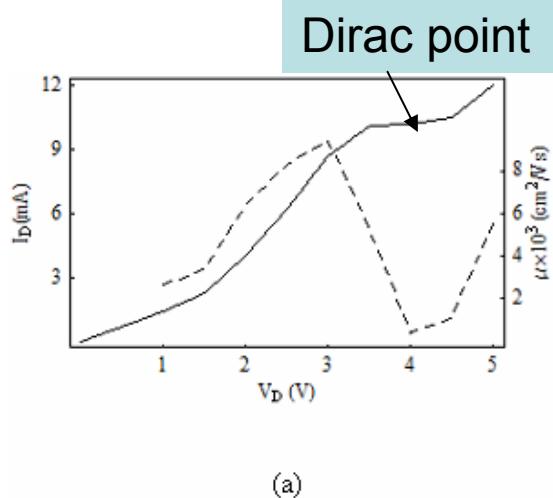
Develop PMMA

Cr/Au evaporation

Lift off



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Conclusions:

Mobility $\approx 9000 \text{ cm}^2/\text{Vs}$ in the FET channel (9 times grater than in CMOS transitors)

Gain > 10 GHz

Cutoff frequency >80 GHz

We will reduce the gate dielectric to 80 nm

Gate length<100 nm

Expected cutoff frequency 0.4-1 THz